

Spin noise spectroscopy in GaAs

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We observe the noise spectrum of electron spins in bulk GaAs by Faraday rotation noise spectroscopy. The experimental technique enables the undisturbed measurement of the electron spin dynamics in semiconductors. We measure exemplarily the electron spin relaxation time and the electron Landé g -factor in n -doped GaAs at low temperatures and find good agreement of the measured noise spectrum with an unpretentious theory based on Poisson distribution probability.

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The inexorable decrease of structure size in semiconductor devices inevitably leads from today's quasi-classical devices to quantum mechanical devices. These quantum mechanical devices might rely not only on the charge of electrons, i.e. on the spatial part of the electron wave function, but also on the much more robust spin part of the wave function. The robustness of the electron spin motivates the current extensive research on the spin dynamics in semiconductors and might lead to spintronic devices with superior functionality and to the enchainning goal of spin quantum information processing [1, 2, 3].

One important signature of the spin dynamics in semiconductors results from the thermal fluctuations of electron spin occupation in the conduction band which fluctuates on the time scale of the spin lifetime and gives rise to spin noise. This kind of spin noise has been observed recently in rubidium gas atoms [4] and theoretically exploited for spin currents through single quantum dots [5]. The experimental observation of spin noise in semiconductors is however a major challenge since the photon shot noise in optical experiments and the Coulomb shot noise in electrical experiments is usually orders of magnitude larger than the spin noise. On the other hand, measurement of the spin noise in semiconductors has the power to become an important experimental tool since the spin noise spectrum yields not only information about the electron Landé g -factor but also promises to give insight into electron-electron spin correlations, spin phase transitions, and spin fluctuations in low-dimensional semiconductor structures. Additionally, spin noise spectroscopy has the advantage to detect optically the spin dynamics in semiconductors without optical excitation of electrons and holes.

This Letter presents an experimental and theoretical description of the spin noise in semiconductors. The experimental setup is schematically depicted in Fig. 1. The optical measurements are performed on a $370\ \mu\text{m}$ thick GaAs wafer with a silicon n -doping of $1.8 \times 10^{16}\ \text{cm}^{-3}$ by Faraday-rotation spectroscopy. The light of a cw laser diode is sent through a spatial filter, linearly polarized by a Glan Thompson polarizer, and focused on the GaAs

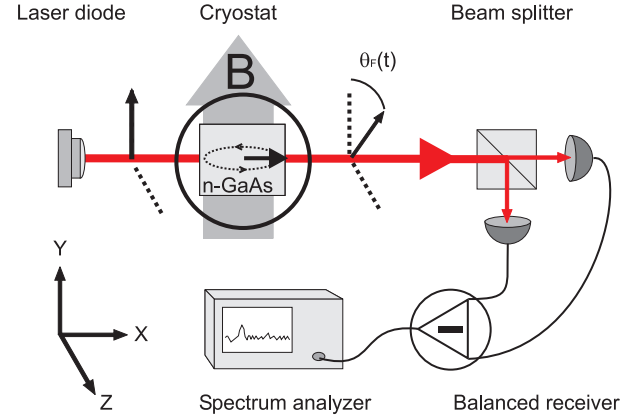


FIG. 1: (color online) Schematic of the experiment. Thermodynamic fluctuations of the electron spins in n -doped GaAs precess around an external magnetic field. The precessing spin fluctuations cause oscillations of the Faraday rotation signal θ_F whose power spectrum is detected by a balanced receiver and a spectrum analyzer.

sample which is mounted in Voigt geometry in a superconducting split-coil magnet with variable temperature insert. The laser wavelength is tuned 10 nm below the GaAs band-gap to minimize absorption and maximize the Faraday rotation signal. The focus diameter of the laser is about $65\ \mu\text{m}$. The linearly polarized light passing through the sample is split by a polarizing beam splitter into two components, linearly polarized $\pm 45^\circ$ with respect to the initial polarization. The two components are focused on a pair of photo diodes of a NewFocus 650 MHz balanced photo receiver and the time varying difference of the two - equally strong if temporally averaged - components is converted with a gain of 350 V/W into voltage and measured by an HP spectrum analyzer. The laser intensity before the beam splitter is 1.9 mW resulting in a white photon shot noise of $10\ \text{nV}/\sqrt{\text{Hz}}$. The electrical noise of the combination of balanced receiver and spectrum analyzer is $13\ \text{nV}/\sqrt{\text{Hz}}$ [6]. We can distinguish between the large external noise sources and the small spin noise by applying a weak magnetic field to the sample perpendicular to the direction of the laser light

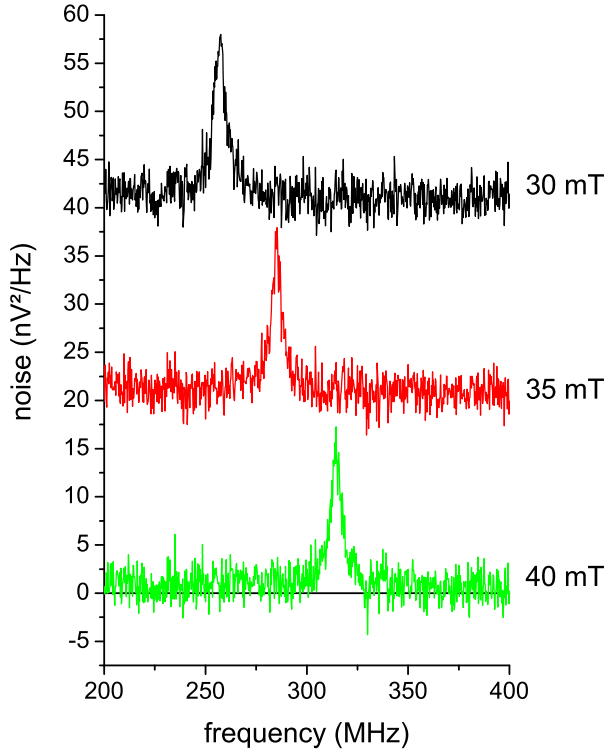


FIG. 2: (color online) Spectrum of the spin noise for different applied magnetic fields. The white photon shot noise and electrical noise power are subtracted. The spectra are vertically shifted for clarity. The sample temperature is 10 K. Frequency and width of the spin noise spectrum are a direct measure of the electron Landé g -factor and the electron spin relaxation time, respectively.

propagation. The spin noise strongly depends on the magnetic field since any statistical imbalance of the electron spin ensemble precesses around the magnetic field resulting in a spin noise peak at the precession frequency. The width of the spin noise peak is proportional to the spin relaxation rate, which includes diffusion of the thermal spin fluctuations out of the laser focus. The white photon and electron noise powers do not depend on the magnetic field and therefore can be easily subtracted.

Figure 2 depicts the measured spin noise spectra for three magnetic fields. The power spectrum at each magnetic field is averaged over 62 measurements á 10 minutes and subtracted by interleaving 62 measurements á 10 minutes at zero magnetic field to subtract the photon and electrical noise. We alternate between finite and zero magnetic field to eliminate any influence of thermal drift in the electronics. The spin noise maxima in Fig. 2 shift linearly with B since the spin precession frequency and therefore the spin noise frequency is directly proportional to B . The width of the spin noise spectra is about 7 MHz yielding a spin relaxation time of about 45 ns. This spin relaxation time is consistent with earlier measurements by Dzhiyev et al. who measure 50 ns for lo-

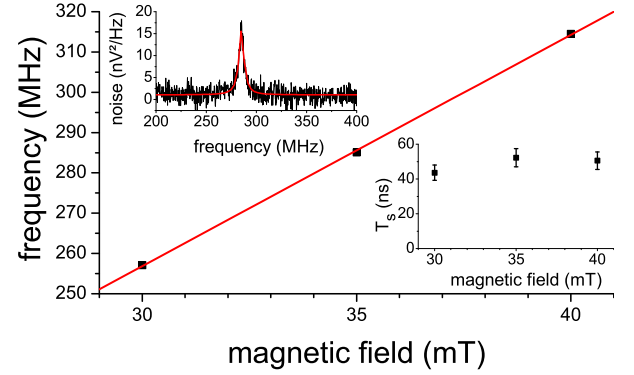


FIG. 3: (color online) Frequency of the maximum of the spin noise (filled squares) and spin relaxation time T_s determined from the full-width half-maximum (right inset) versus magnetic field B . The slope of the linear fit to the frequency (solid line) yields an electron Landé g -factor of -0.41 ± 0.01 . The fit does not extrapolate to $f \rightarrow 0$ for $B \rightarrow 0$ due to a known constant remanent field of the superconducting magnet, which was not subtracted in this figure. The upper, left inset depicts the Lorentzian fit to the noise spectra at 35 mT.

calized donor bound electrons in GaAs with an n -doping of $1.5 \times 10^{16} \text{ cm}^{-3}$ [7].

Figure 3 depicts the maxima of the spin noise peaks versus B . The spin precession frequency is equal to $g_e \mu_B B / h$, where g_e is the electron Landé g -factor, μ_B is Bohr's magneton, and h is Planck's constant. The slope of the measured noise frequency f versus B yields $g_e = -0.41 \pm 0.01$ which is in excellent agreement with optically oriented and detected electron spin resonance in lightly doped n -GaAs [8] confirming that the measured spin noise is in fact correlated with donor bound electrons. The width of the noise spectra is a measure of the spin relaxation time (right inset in Fig. 3), which is within the measurement error independent of B , i.e., the spin relaxation measurement is not obscured by inhomogeneous broadening of g_e .

In the following, we want to theoretically estimate the amplitude of the spin noise and compare the results with our measurements. We make the simplifying assumption that the statistical fluctuation of the electron spin polarization along the light propagation is proportional to $\sqrt{N}$, where N is the number of donor bound electrons in the volume V of the laser. In our experiment, this is a good approximation since the electrons are localized at the donors and the Poisson prerequisite of independent events is therefore fulfilled. The experiment fortifies the assumption since we do not observe a temperature dependence of the width and the height of the noise peak when we increase the temperature from 5 K to 10 K, i.e. the area under the noise peak stays constant. The localization of the electrons has additionally been verified by temperature dependent transport measurements. We calculate the change of the valence band to donor absorp-

tion $\Delta\alpha$ due to the electron spin fluctuations in the style of Dumke [9]

$$\Delta\alpha = \frac{64e^2\langle|p_{cv}|^2\rangle E_v^{1/2}}{\epsilon_0 n c m_0^2 \omega (m_e E_D)^{3/2}} \left(\frac{m_{hh}^{3/2}}{[1 + (m_{hh} E_v / m_e E_D)]^4} - \frac{m_{lh}^{3/2}}{[1 + (m_{lh} E_v / m_e E_D)]^4} \right) \sqrt{N}/V \quad (1)$$

where e is the electron charge, $\langle|p_{cv}|^2\rangle = 2.1 \times 10^{-48} \text{ kg}^2 \text{m}^2/\text{s}^2$ the average of the squared matrix element for transitions between Bloch states, $E_v = (\hbar\omega + E_D - E_g)$, $E_D = 0.06 \text{ meV}$ the donor binding energy, $E_g = 1.517 \text{ eV}$ the direct band gap energy, $m_{hh} = 0.45 m_0$ and $m_{lh} = 0.082 m_0$ the heavy and light hole masses, respectively, $n = 3.6$ the refractive index, c the velocity of light, ω the light frequency, m_0 the free electron mass and $m_e = 0.067 m_0$ the effective electron mass in the conduction band. The minus sign results from the optical selection rules which couple for a given circular polarization heavy hole and light hole to opposite electron spin states. Applying Kramers–Kronig relation to $\Delta\alpha$ yields the average change in refractive index for right- (σ^+) and left-circularly (σ^-) polarized light and thereby the average Faraday rotation angle. The change of refractive index Δn at 825 nm due to the thermal fluctuations becomes in our sample $\Delta n \approx 2.4 \times 10^{-8}$ and the resulting Faraday rotation angle $\Theta_F \approx 7 \times 10^{-5} \text{ rad}$. The calculated maximum of the noise peak for a spin relaxation time of 45 ns is $9 \times 10^{-17} \text{ V}^2/\text{Hz}$. This calculated noise is for the simplicity of the calculation, which does not include trionic effects [10], and the uncertainties in the experimental parameters in good agreement with the measured $1.5 \times 10^{-17} \text{ V}^2/\text{Hz}$.

All measurements have been carried out at low temperatures where electrons are localized and the noise signal is temperature independent. At higher temperatures the donor bound electrons become delocalized and the distribution of the electrons in the conduction band follows a Maxwell–Boltzmann distribution. The average size of fluctuations $\sigma_{N^+-N^-}^2$ of the absolute spin orientation is expected to be for the Maxwell–Boltzmann distribution - as in the localized case - temperature independent and equal to N . Nevertheless, the Faraday rotation signal should become temperature dependent since $\Delta\alpha$ broadens and moves in energy with increasing temperature. The independence of σ^2 on temperature will change to a strong temperature dependence in samples with higher electron densities where the electron distribution is a Fermi–Dirac distribution $f(E)$ with

$$\sigma_{N^+-N^-}^2 = V \int_{E_{\text{gap}}}^{\infty} \text{DOS}(E) f(E) (1 - f(E)) dE, \quad (2)$$

where DOS is the density of states. For Fermi–Dirac distributions,

$$\lim_{T \rightarrow 0} \sigma_{N^+-N^-} = 0 \quad \text{and} \quad \lim_{T \rightarrow \infty} \sigma_{N^+-N^-} = \sqrt{N},$$

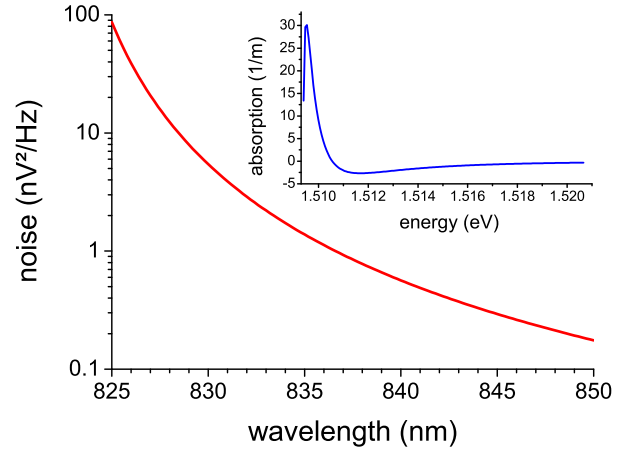


FIG. 4: (color online) Calculated maximum of the electron spin noise signal in dependence on detection wavelength for our experimental parameters. The same calculations for p -doped GaAs yields a signal which is five orders of magnitude smaller due to the much faster spin relaxation of free holes. The inset depicts the change of absorption due to the thermal fluctuations of the electron spins in dependence on energy [eqn. (1)].

with a most pronounced temperature dependence between $T = 0$ and $k_B T \leq E_F$, where k_B is Boltzmann's constant and E_F is the Fermi energy.

We expect spin noise spectroscopy to have a wide range of applications in semiconductors. As an example we show in the following that spin noise is in principle capable to measure intrinsic electron spin relaxation times at low temperature with less uncertainties than traditional Faraday rotation or Hanle measurements. The intrinsic electron spin relaxation time recently gained new interest, since experiments and calculations by Beck et al. at 4 K adumbrate that the electron spin relaxation times in GaAs with an n -doping in the range between 10^{15} cm^{-3} and 10^{16} cm^{-3} might not be limited by the anisotropic exchange interaction [11] but by the Dyakonov–Perel (DP) mechanism [12]. The DP mechanism vanishes for electrons with wave vectors $|\vec{k}| \rightarrow 0$. Therefore low electron temperatures and the absence of additional spin relaxation mechanism are required for long spin relaxation times. These requirements are extremely difficult to achieve in traditional Faraday rotation and Hanle measurements for two reasons. Firstly, the carrier temperatures are intrinsically higher than the sample temperature and secondly, the optically injected holes cause additional spin relaxation due to the well known Bir–Aronov–Pikus (BAP) mechanism [13]. The temperature of the optically injected carriers are at low sample temperatures intrinsically higher than the sample temperature since even resonant optical excitation (excitation of the n -doped semiconductor at the Fermi edge) yields hot holes with high k values and carrier cooling at low temperatures is extremely inefficient due to the in-

efficient coupling of carriers with acoustic phonons [14]. Secondly, spin relaxation due to holes by the BAP mechanism is difficult to rule out since carrier recombination times become extremely long at low carrier concentration. The importance of BAP even at lowest pump intensities has been nicely demonstrated by several groups (see e.g. Ref. [7], inset of Fig. 2). Spin noise measurements on the other hand do not necessarily excite carriers and thereby circumvent the above problems including the sometimes displeasing dynamical nuclear spin polarization. Since the amplitude of the spin noise signal is proportional to the spin relaxation time, spin noise spectroscopy particularly qualifies for systems with long spin relaxation times.

To evidence that spin noise measurements are sufficiently sensitive even below the band tail absorption, we have calculated the Faraday rotation noise signal in dependence on wavelength (see Figure 4). The noise power decreases by two order of magnitude when we increase the excitation wavelength from 825 nm to 840 nm. At 825 nm about 90 % of the light is absorbed in our $370\text{ }\mu\text{m}$ thick GaAs sample yielding an excitation density of $5 \times 10^{14}\text{ cm}^{-3}$ assuming a radiative carrier life time of 10 ns. At 840 nm the absorption is nearly negligible. We have also calculated the Faraday rotation signal for non-localized electrons, e.g. in modulation doped GaAs, and find at the same electron temperature a signal decrease of only one order of magnitude at 840 nm and two orders of magnitude at 900 nm. We have to compare these decreases in noise power signal with the signal-to-noise ratio in Fig. 2. Keeping in mind the deficiencies of our present experiment we are confident that even two orders of magnitude lower doping concentrations should be measurable since the noise signal decreases only with the square root of the doping concentration.

In conclusion, we have measured the spin dynamics in *n*-doped bulk GaAs by spin noise spectroscopy. The sensitive technique allows the disturbance free measurement of the spin dynamics in semiconductors with high accuracy. The measurements show in combination with calculations that spin noise spectroscopy in semiconduc-

tors is a powerful tool, circumvents common problems of carrier heating and injection of interfering holes, and promises new insight into spin relaxation, magnetization dynamics, and electron-spin correlations.

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